

Search Notes

Application/Control No.

10/523,170

Examiner

John D. Lee

Applicant(s)/Patent under
Reexamination

KURIMURA ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
359	326-332, 341.1	7/6/2006	JDL
385	122	7/6/2006	JDL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO "WEST" Database searched; search strategy on separate sheet.	7/6/2006	JDL